

<b>Search Notes</b> 	<b>Application/Control No.</b>	<b>Applicant(s)/Patent under Reexamination</b>	
	10/780,244	HEO ET AL.	
	<b>Examiner</b> Remmon R. Fordé	<b>Art Unit</b> 2826	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

The image consists of two horizontal black lines. The top line is a simple horizontal segment with two vertical tick marks on its right side. The bottom line is a horizontal segment with a vertical tick mark on its left side and two vertical tick marks on its right side, forming a T-shape.